



HT32F50020/HT32F50030

Datasheet

**32-Bit Arm® Cortex®-M0+ 5V Microcontroller,
up to 32 KB Flash and 2 KB SRAM with 500 ksps ADC,
UART, SPI, I²C, SCTM, BFTM, LEDC, RTC and WDT**

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1 General Description

The Holtek HT32F50020/HT32F50030 devices are high performance, low power consumption 32-bit microcontrollers based around an Arm® Cortex®-M0+ processor core. The Cortex®-M0+ is a next-generation processor core which is tightly coupled with Nested Vectored Interrupt Controller (NVIC), SysTick timer and including advanced debug support.

The devices operate at a frequency of up to 16 MHz to obtain maximum efficiency. It provides up to 32 KB of embedded Flash memory for code/data storage and 2 KB of embedded SRAM memory for system operation and application program usage. A variety of peripherals, such as ADC, I²C, UART, SPI, SCTM, BFTM, LEDC, RTC, WDT and SW-DP (Serial Wire Debug Port), etc., are also implemented in the devices. Several power saving modes provide the flexibility for maximum optimization between wakeup latency and power consumption, an especially important consideration in low power applications.

The above features ensure that the devices are suitable for use in a wide range of applications, especially in areas such as white goods application controllers, power monitors, alarm systems, consumer products, handheld equipment, data logging applications, motor control and so on.

arm CORTEX

2 Features

Core

- 32-bit Arm® Cortex®-M0+ processor core
- Up to 16 MHz operating frequency
- Single-cycle multiplication
- Integrated Nested Vectored Interrupt Controller (NVIC)
- 24-bit SysTick timer

The Cortex®-M0+ processor is a very low gate count, highly energy efficient processor that is intended for microcontroller and deeply embedded applications that require an area optimized, low-power processor. The processor is based on the ARMv6-M architecture and supports Thumb® instruction sets, single-cycle I/O ports, hardware multiplier and low latency interrupt respond time.

On-Chip Memory

- Up to 32 KB on-chip Flash memory for instruction/data and option byte storage
- 2 KB on-chip SRAM
- Supports multiple boot modes

The Arm® Cortex®-M0+ processor access and debug access share the single external interface to external AHB peripherals. The processor access takes priority over debug access. The maximum address range of the Cortex®-M0+ is 4 GB since it has a 32-bit bus address width. Additionally, a pre-defined memory map is provided by the Cortex®-M0+ processor to reduce the software complexity of repeated implementation by different device vendors. However, some regions are used by the Arm® Cortex®-M0+ system peripherals. Refer to the Arm® Cortex®-M0+ Technical Reference Manual for more information. Figure 2 in the Overview chapter shows the memory map of the HT32F50020/HT32F50030 series devices, including code, SRAM, peripheral and other pre-defined regions.

Flash Memory Controller – FMC

- 32-bit word programming with In System Programming (ISP) and In Application Programming (IAP)
- Flash protection capability to prevent illegal access

The Flash Memory Controller, FMC, provides all the necessary functions for the embedded on-chip Flash Memory. The word programming/page erase functions are also provided.

Reset Control Unit – RSTCU

- Supply supervisor
 - Power On Reset / Power Down Reset – POR / PDR
 - Brown-out Detector – BOD
 - Programmable Low Voltage Detector – LVD

The Reset Control Unit, RSTCU, has three kinds of reset, a power on reset, a system reset and an APB unit reset. The power on reset, known as a cold reset, resets the full system during power up. A system reset resets the processor core and peripheral IP components with the exception of the SW-DP controller. The resets can be triggered by external signals, internal events and the reset generators.

Clock Control Unit – CKCU

- External 4 to 16 MHz crystal oscillator
- External 32.768 kHz crystal oscillator
- Internal 16 MHz RC oscillator trimmed to $\pm 1\%$ accuracy at 25 °C operating temperature
- Internal 32 kHz RC oscillator
- Independent clock divider and gating bits for peripheral clock sources

The Clock Control Unit, CKCU, provides a range of oscillator and clock functions. These include a High Speed Internal RC oscillator (HSI), a High Speed External crystal oscillator (HSE), a Low Speed Internal RC oscillator (LSI), a Low Speed External crystal oscillator (LSE), an HSE clock monitor, clock pre-scalers, clock multiplexers, APB clock divider and gating circuitry. The AHB, APB and Cortex®-M0+ clocks are derived from the system clock (CK_SYS) which can come from the HSI, HSE, LSI or LSE. The Watchdog Timer and Real-Time Clock (RTC) use either the LSI or LSE as their clock source.

Power Management Control Unit – PWRCU

- Single V_{DD} power supply: 2.5 V ~ 5.5 V
- Integrated 1.5 V LDO regulator for MCU core, peripherals and memories power supply
- Two power domains: V_{DD} and V_{CORE} power domains
- Three power saving modes: Sleep, Deep-Sleep1, Deep-Sleep2

Power consumption can be regarded as one of the most important issues for many embedded system applications. Accordingly the Power Control Unit, PWRCU, in the device provides many types of power saving modes such as Sleep, Deep-Sleep1 and Deep-Sleep2 modes. These operating modes reduce the power consumption and allow the application to achieve the best trade-off between the conflicting demands of CPU operating time, speed and power consumption.

External Interrupt/Event Controller – EXTI

- Up to 8 EXTI lines with configurable trigger source and type
- All GPIO pins can be selected as EXTI trigger source
- Source trigger type includes high level, low level, negative edge, positive edge or both edges
- Individual interrupt enable, wakeup enable and status bits for each EXTI line
- Software interrupt trigger mode for each EXTI line
- Integrated deglitch filter for short pulse blocking

The External Interrupt/Event Controller, EXTI, comprises 8 edge detectors which can generate a wake-up event or interrupt requests independently. Each EXTI line can also be masked independently.

Analog to Digital Converter – ADC

- 12-bit SAR ADC engine
- Up to 500 ksps conversion rate
- Up to 12 external analog input channels

A 12-bit multi-channel Analog to Digital Converter is integrated in the device. There are multiplexed channels, which include up to 12 external analog signal channels and 2 internal channels which can be measured. There are two conversion modes to convert an analog signal to digital data. The A/D conversion can be operated in one shot and continuous conversion mode.

The internal voltage reference generator (VREF) which can provide a stable ADC reference positive voltage (ADCREFP) and the Band gap of VREF is internally connected to the ADC internal input channel. The precise voltage of the V_{REF} is individually measured for each part by Holtek during production test.

I/O Ports – GPIO

- Up to 42 GPIOs
- Port A, B, C, F are mapped as 8-line EXTI interrupts
- Almost all I/O pins have configurable output driving current

There are up to 42 General Purpose I/O pins, GPIO, named PA0 ~ PA15, PB0 ~ PB15, PC0 ~ PC7, PF0 ~ PF1, for the implementation of logic input/output functions. Each of the GPIO ports has a series of related control and configuration registers to maximize flexibility and to meet the requirements of a wide range of applications.

The GPIO ports are pin-shared with other alternative functions to obtain maximum functional flexibility on the package pins. The GPIO pins can be used as alternative functional pins by configuring the corresponding registers regardless of the input or output pins. The external interrupts on the GPIO pins of the device have related control and configuration registers in the External Interrupt Control Unit, EXTI.

Single-Channel Timer – SCTM

- 16-bit auto-reload up-counter
- One channel for each timer
- 8-bit programmable prescaler that allows division of the prescaler clock source by any factor between 1 and 256 to generate the counter clock frequency
- One input Capture function
- Two compare Match Output
- PWM waveform generation with Edge-aligned counting Mode
- Single Pulse Mode Output

The Single Channel Timer Module, SCTM, consists of one 16-bit up-counter, one 16-bit Capture/Compare Register (CCR), one 16-bit Counter Reload Register (CRR) and several control/status registers. It can be used for a variety of purposes including general timer, input signal pulse width measurement or output waveform generation such as PWM outputs.

Basic Function Timer – BFTM

- 16-bit compare match up-counter – no I/O control
- One shot mode – counter stops counting when compare match occurs
- Repetitive mode – counter restarts when compare match occurs

The Basic Function Timer Module, BFTM, is a simple 16-bit up-counting counter designed to measure time intervals and generate one shots or generate repetitive interrupts. The BFTM can operate in two functional modes, repetitive and one shot modes. In the repetitive mode, the counter will restart at each compare match event. The BFTM also supports a one shot mode which will force the counter to stop counting when a compare match event occurs.

Watchdog Timer – WDT

- 12-bit down-counter with 3-bit prescaler
- Provides reset to the system
- Programmable watchdog timer window function
- Register write protection function

The Watchdog Timer is a hardware timing circuit that can be used to detect a system lock-up due to software trapped in a deadlock. It includes a 12-bit down-counter, a prescaler, a WDT delta value register, WDT operation control circuitry and a WDT protection mechanism. If the software does not reload the counter value before a Watchdog Timer underflow occurs, a reset will be generated when the counter underflows. In addition, a reset is also generated if the software reloads the counter before it reaches a delta value. It means that the counter reload must occur when the Watchdog timer value has a value within a limited window using a specific method. The Watchdog Timer counter can be stopped when the processor is in the debug mode. The register write protection function can be enabled to prevent an unexpected change in the Watchdog Timer configuration.

Real-Time Clock – RTC

- 24-bit up-counter with a programmable prescaler
- Alarm function
- Interrupt and Wake-up event

The Real-Time Clock, RTC, circuitry includes the APB interface, a 24-bit up-counter, a control register, a prescaler, a compare register and a status register. The RTC circuits are located in the V_{CORE} power domain. The RTC counter is used as a wakeup timer to generate a system resume or interrupt signal from the MCU power saving mode.

Inter-integrated Circuit – I²C

- Supports both master and slave modes with a frequency of up to 1 MHz
- Supports 7-bit addressing mode and general call addressing
- Supports two 7-bit slave addresses

The I²C module is an internal circuit allowing communication with an external I²C interface which is an industry standard two line serial interface used for connection to external hardware. These two serial lines are known as a serial data line, SDA, and a serial clock line, SCL. The I²C module provides three data transfer rates: 100 kHz in the Standard mode, 400 kHz in the Fast mode and 1 MHz in the Fast plus mode. The SCL period generation register is used to setup different kinds of duty cycle implementations for the SCL pulse.

The SDA line which is connected directly to the I²C bus is a bidirectional data line between the master and slave devices and is used for data transmission and reception.

Serial Peripheral Interface – SPI

- Supports both master and slave modes
- Frequency of up to ($f_{\text{CLK}}/2$) MHz for the master mode and ($f_{\text{CLK}}/3$) MHz for the slave mode
- Programmable data frame length up to 8 bits
- FIFO Depth: 4 levels

The Serial Peripheral Interface, SPI, provides an SPI protocol data transmit and receive function in both master and slave modes. The SPI interface uses 4 pins, among which are serial data input and output lines MISO and MOSI, the clock line, SCK, and the slave select line, SEL. One SPI device

acts as a master device which controls the data flow using the SEL and SCK signals to indicate the start of data communication and the data sampling rate. To receive a data byte, the streamlined data bits are latched on a specific clock edge and stored in the data register or in the RX FIFO. Data transmission is carried out in a similar way but in a reverse sequence.

Universal Asynchronous Receiver Transmitter – UART

- Asynchronous serial communication operating baud-rate clock frequency up to ($f_{PCLK}/16$) MHz
- Full duplex communication
- Fully programmable serial communication characteristics including:
 - Word length: 7, 8 or 9-bit character
 - Parity: Even, odd or no-parity bit generation and detection
 - Stop bit: 1 or 2 stop bits generation
 - Bit order: LSB-first or MSB-first transfer
- Error detection: Parity, overrun and frame error

The Universal Asynchronous Receiver Transceiver, UART, provides a flexible full duplex data exchange using asynchronous transfer. The UART is used to translate data between parallel and serial interfaces, and is commonly used for RS232 standard communication. The UART peripheral function supports Line Status Interrupt. The software can detect a UART error status by reading the UART Status & Interrupt Flag Register, URSIFR. The status includes the type and the condition of transfer operations as well as several error conditions resulting from Parity, Overrun, Framing and Break events.

LED Controller – LEDC

- Supports 8-segment digital displays up to 8
- Supports 8-segment digital displays with common anode or common cathode
- Support frame interrupt
- Three clock sources: LSI, LSE and PCLK
- The LED light on/off times can be controlled using the dead time setting

The LED controller is used to drive 8-segment digital displays. These devices can driver 8-segment digital displays up to 8. Users can flexibly configure the pin position and number of the COMs according to the digital displays in the application. In a complete frame period, the enabled COMs will be scanned from the lower to the higher. Taking an example of where four 8-segment LEDs are used and where COM0, COM5, COM6 and COM7 are enabled. Here COM0, COM5, COM6 and the COM7 will be scanned successively in this sequence within a complete frame period. The scanning time of each COM port is equal to 1/4 frame, which is subdivided into the dead time duty and the COM duty. Users can adjust the dead time duty to change the LED brightness.

Debug Support

- Serial Wire Debug Port – SW-DP
- 4 comparators for hardware breakpoint or code / literal patch
- 2 comparators for hardware watch points

Package and Operation Temperature

- 24/28-pin SSOP, 24/32-pin QFN and 48-pin LQFP packages
- Operation temperature range: -40 °C to 85 °C

3 Overview

Device Information

Table 1. Features and Peripheral List

Peripherals		HT32F50020	HT32F50030
Main Flash (KB)		16	31
Option Bytes Flash (KB)		1	1
SRAM (KB)		2	
Timers	SCTM	3	
	BFTM	1	
	WDT	1	
	RTC	1	
Communication	SPI	1	
	UART	2	
	I ² C	1	
EXTI		8	
12-bit ADC		1	
Number of channels		Max.12 external channels	
GPIO		Up to 42	
LEDC		Up to 8 × 8-segment	
CPU frequency		Up to 16 MHz	
Operating voltage		2.5 V ~ 5.5 V	
Operating temperature		-40 °C ~ 85 °C	
Package		24/28-pin SSOP, 24/32-pin QFN and 48-pin LQFP	

Block Diagram

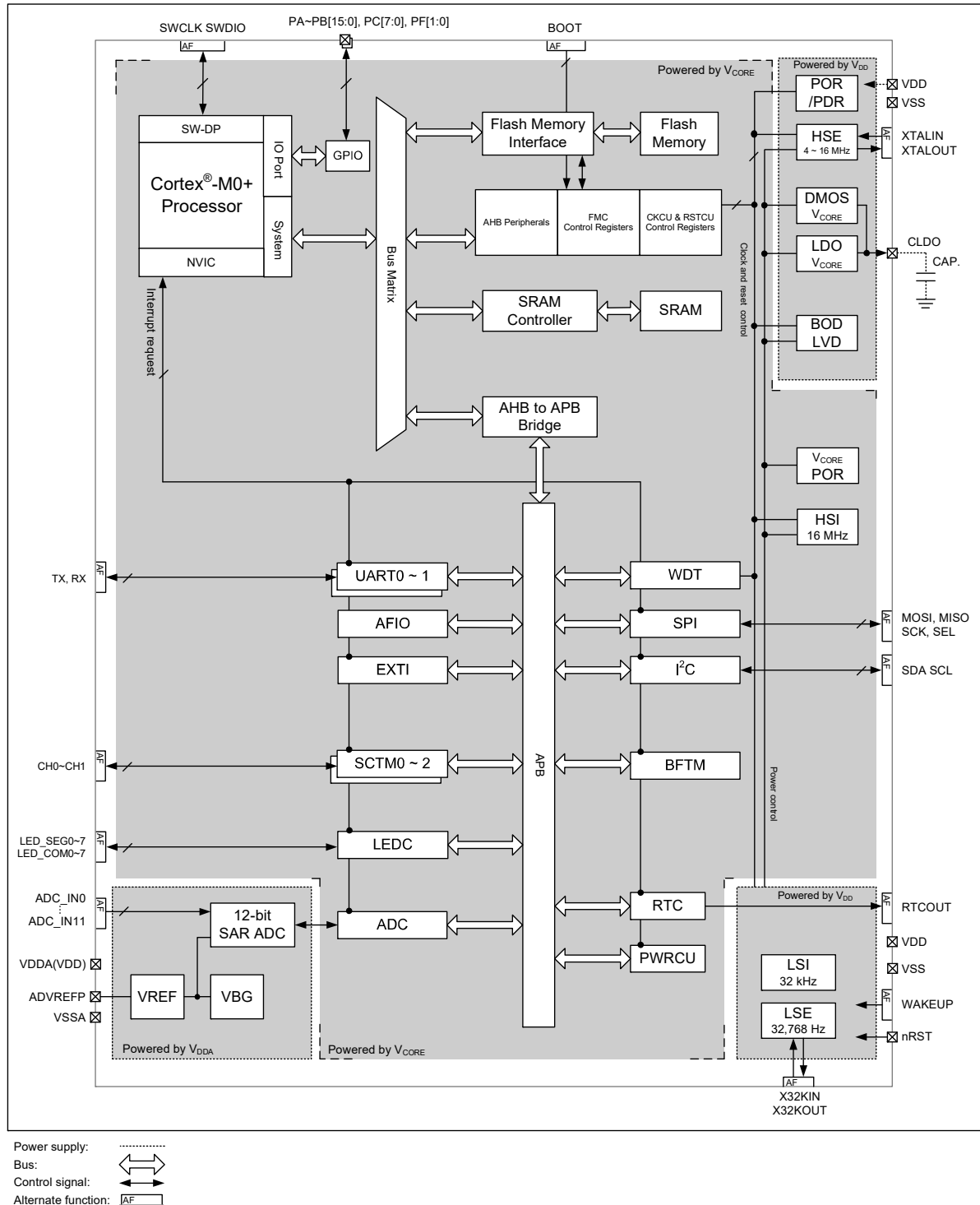


Figure 1. Block Diagram

Memory Map

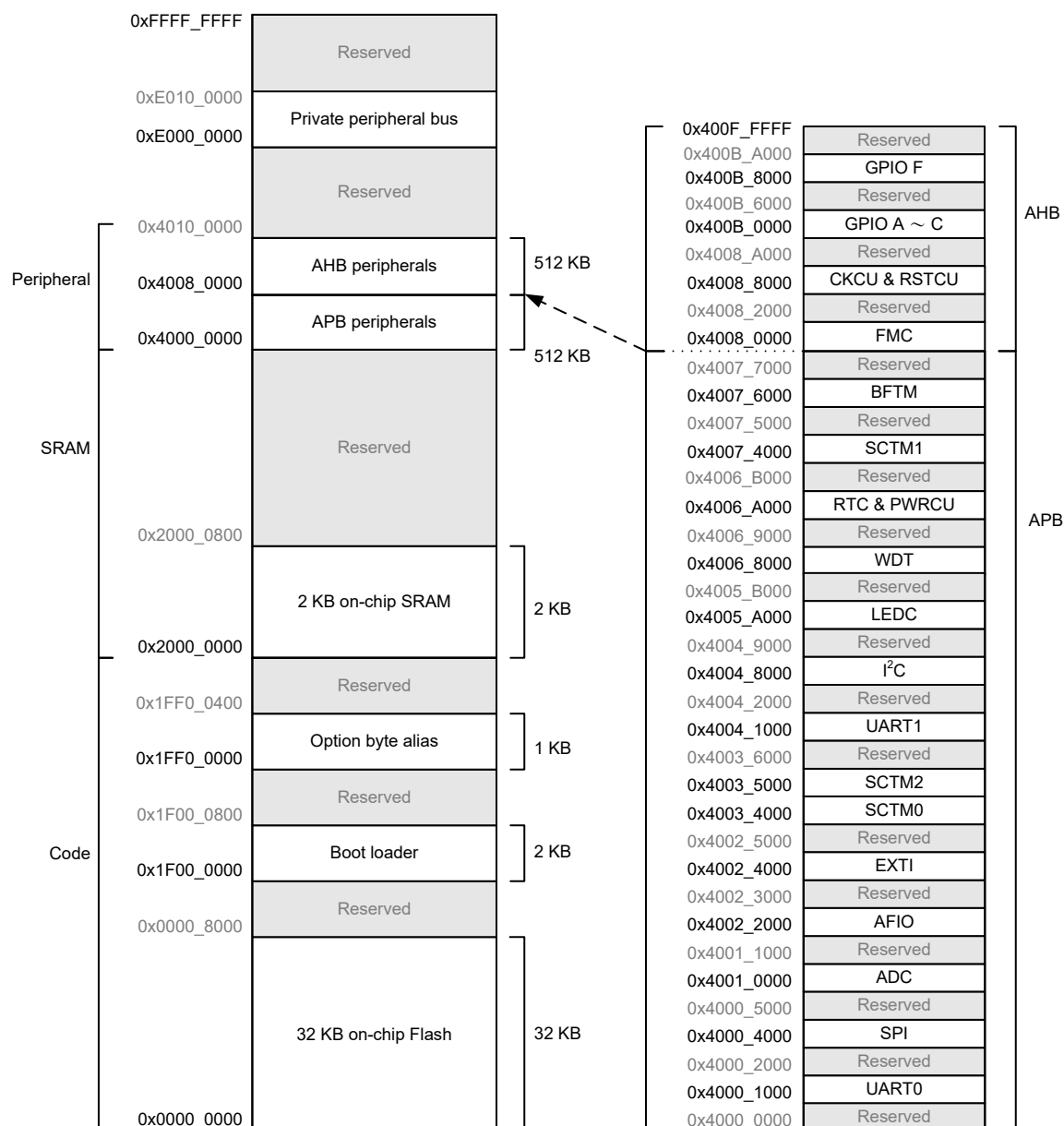


Figure 2. Memory Map

Table 2. Register Map

Start Address	End Address	Peripheral	Bus
0x4000_0000	0x4000_0FFF	Reserved	APB
0x4000_1000	0x4000_1FFF	UART0	
0x4000_2000	0x4000_3FFF	Reserved	
0x4000_4000	0x4000_4FFF	SPI	
0x4000_5000	0x4000_FFFF	Reserved	
0x4001_0000	0x4001_0FFF	ADC	
0x4001_1000	0x4002_1FFF	Reserved	
0x4002_2000	0x4002_2FFF	AFIO	
0x4002_3000	0x4002_3FFF	Reserved	
0x4002_4000	0x4002_4FFF	EXTI	
0x4002_5000	0x4003_3FFF	Reserved	
0x4003_4000	0x4003_4FFF	SCTM0	
0x4003_5000	0x4003_5FFF	SCTM2	
0x4003_6000	0x4004_0FFF	Reserved	
0x4004_1000	0x4004_1FFF	UART1	
0x4004_2000	0x4004_7FFF	Reserved	
0x4004_8000	0x4004_8FFF	I ² C	
0x4004_9000	0x4005_9FFF	Reserved	
0x4005_A000	0x4005_AFFF	LEDC	
0x4005_B000	0x4006_7FFF	Reserved	
0x4006_8000	0x4006_8FFF	WDT	
0x4006_9000	0x4006_9FFF	Reserved	
0x4006_A000	0x4006_AFFF	RTC & PWRCU	
0x4006_B000	0x4007_3FFF	Reserved	
0x4007_4000	0x4007_4FFF	SCTM1	
0x4007_5000	0x4007_5FFF	Reserved	
0x4007_6000	0x4007_6FFF	BFTM	
0x4007_7000	0x4007_FFFF	Reserved	
0x4008_0000	0x4008_1FFF	FMC	AHB
0x4008_2000	0x4008_7FFF	Reserved	
0x4008_8000	0x4008_9FFF	CKCU & RSTCU	
0x4008_A000	0x400A_FFFF	Reserved	
0x400B_0000	0x400B_1FFF	GPIO A	
0x400B_2000	0x400B_3FFF	GPIO B	
0x400B_4000	0x400B_5FFF	GPIO C	
0x400B_6000	0x400B_7FFF	Reserved	
0x400B_8000	0x400B_9FFF	GPIO F	
0x400B_A000	0x400F_FFFF	Reserved	

Clock Structure

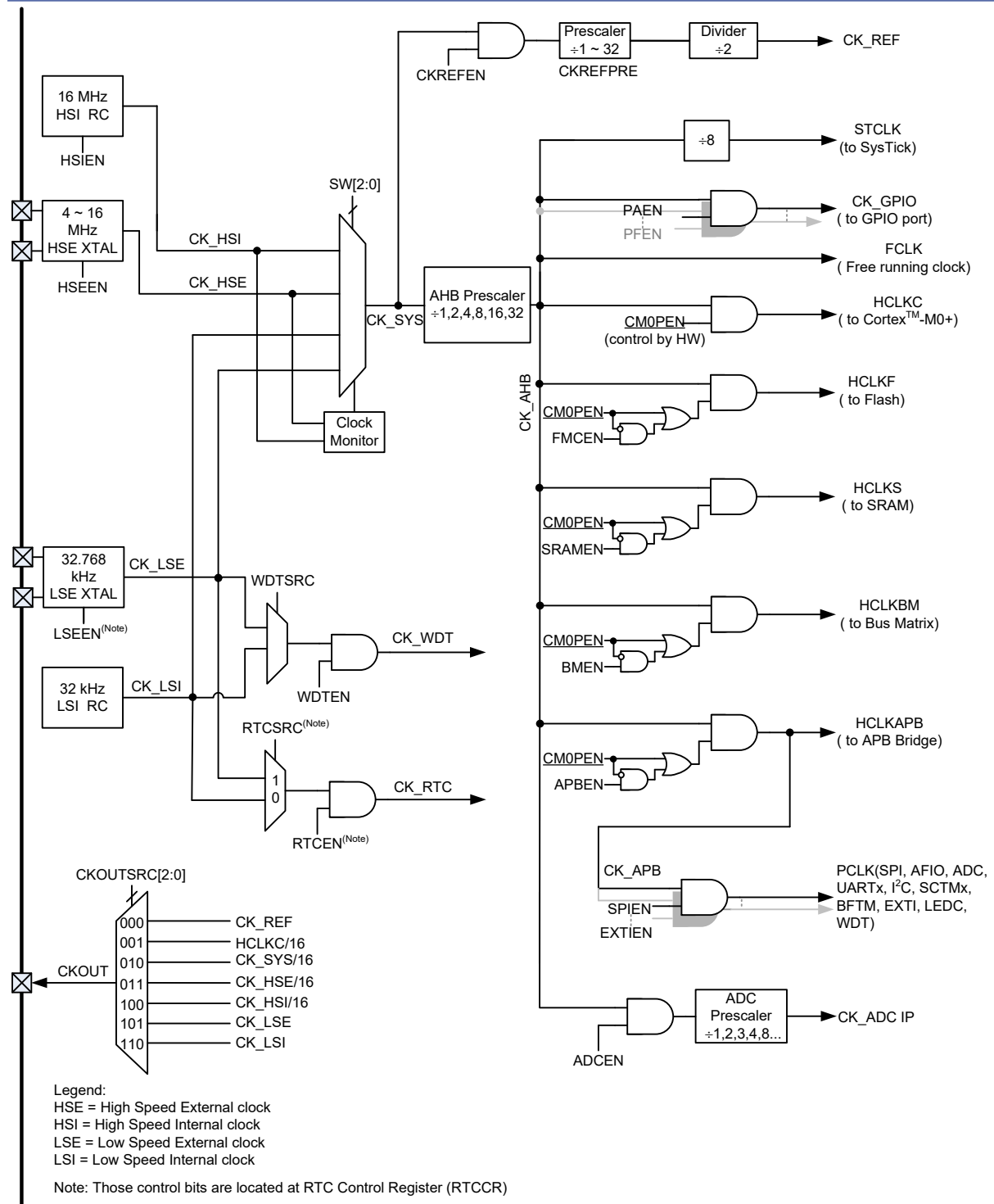


Figure 3. Clock Structure

4 Pin Assignment

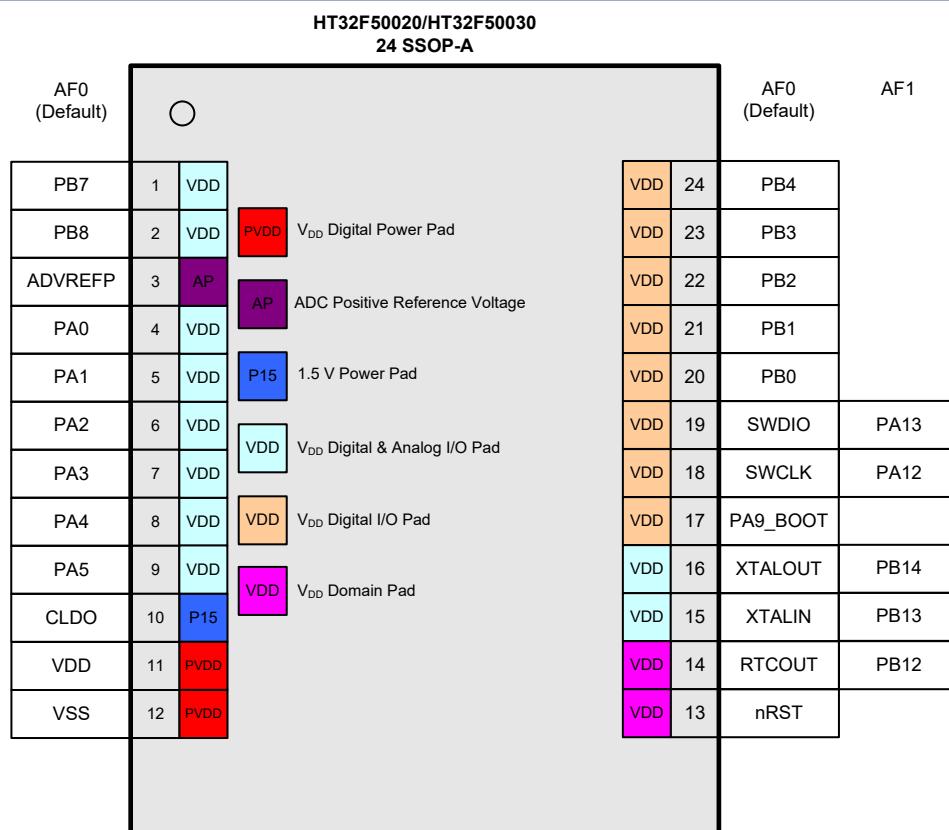


Figure 4. 24-pin SSOP Pin Assignment

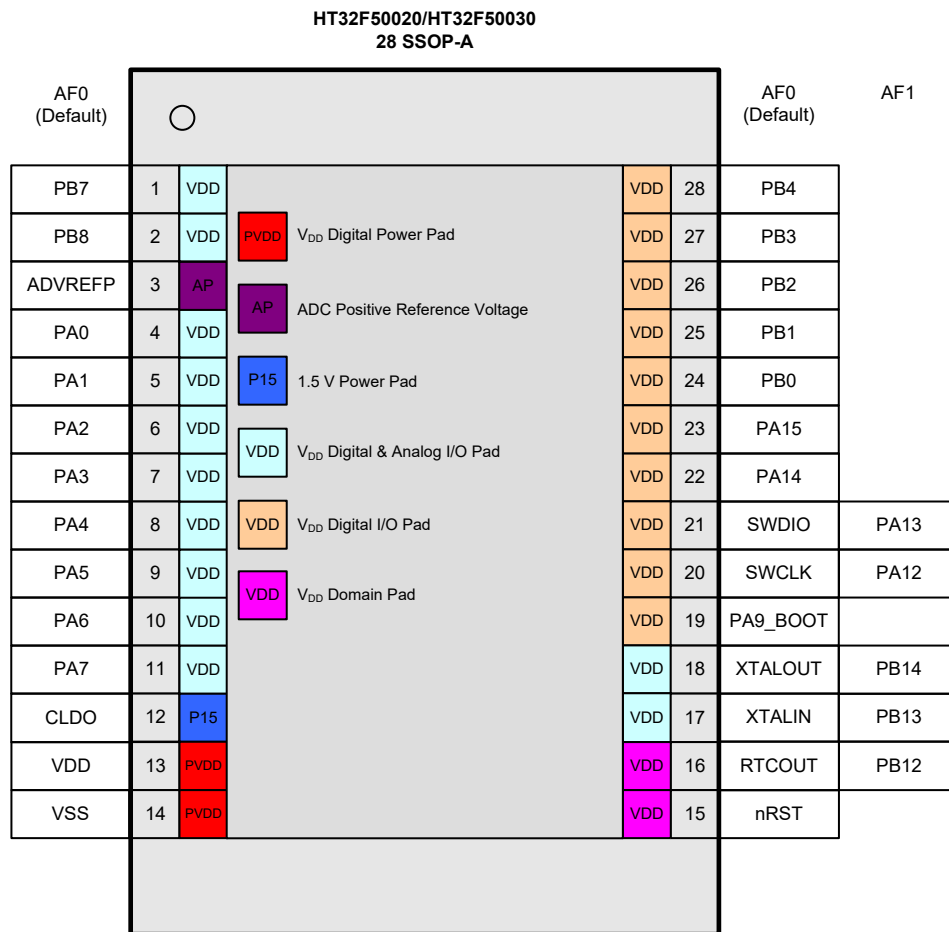


Figure 5. 28-pin SSOP Pin Assignment

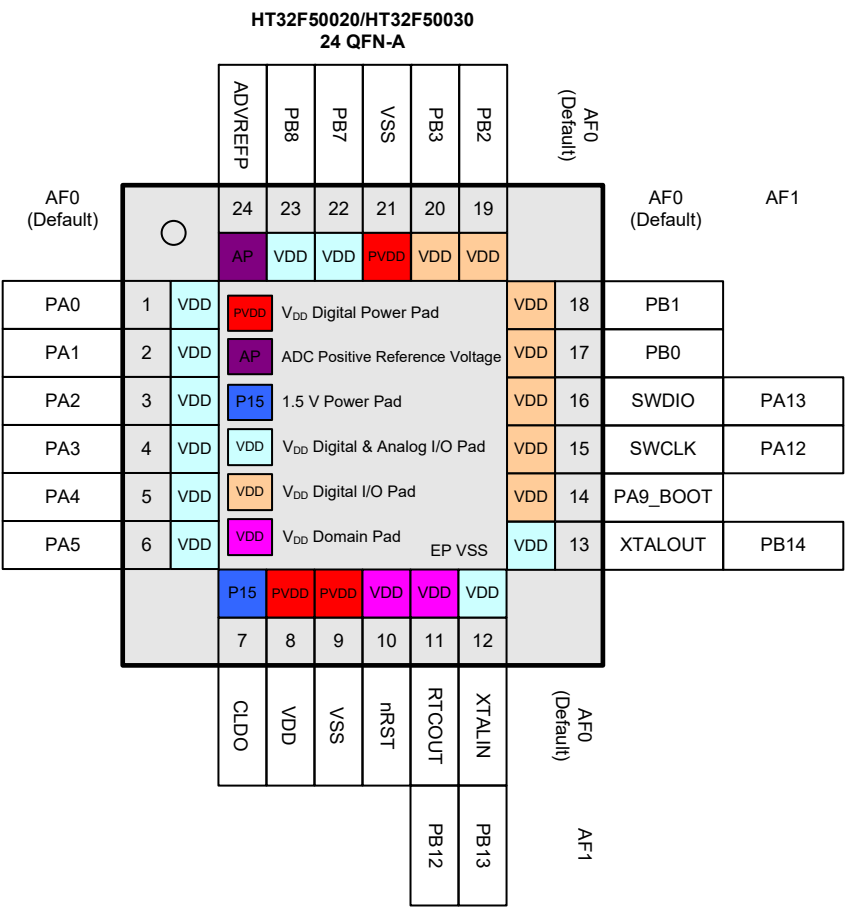


Figure 6. 24-pin QFN Pin Assignment



August 25, 2025

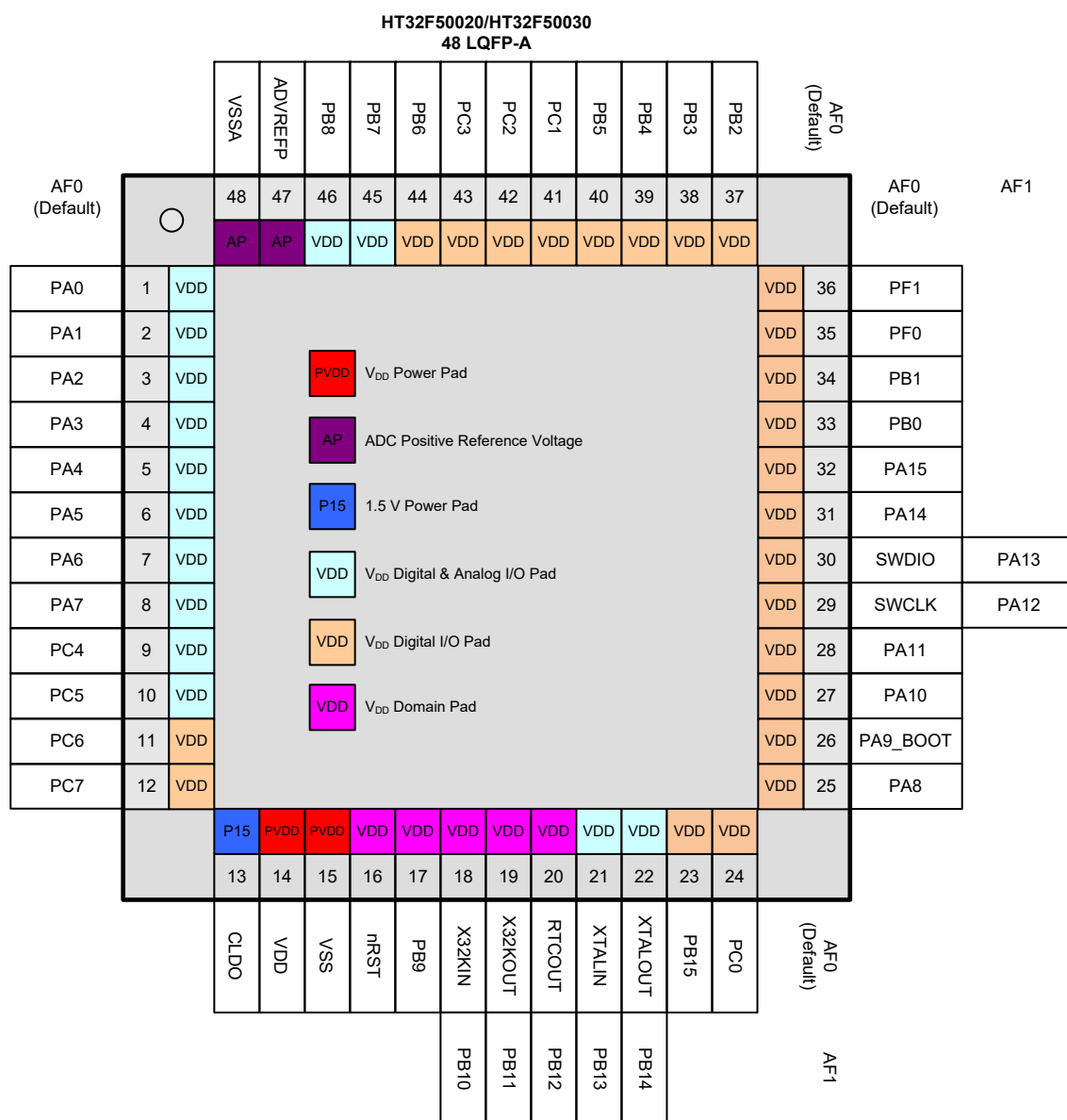


Figure 8. 48-pin LQFP Pin Assignment

Table 3. Pin Assignment

Packages					Alternate Function Mapping							
					AF0	AF1	AF2	AF3	AF4	AF5	AF6	AF7
48 LQFP	32 QFN	28 SSOP	24 SSOP	24 QFN	System Default	System Other	ADC	LEDC	SCTM	SPI	UART	I ² C
1	1	4	4	1	PA0	VBG	ADC_IN2	LED_SEG0	SCTM1_CH0	SPI_SCK		I2C_SCL
2	2	5	5	2	PA1		ADC_IN3	LED_SEG1	SCTM1_CH1	SPI_MOSI		I2C_SDA
3	3	6	6	3	PA2		ADC_IN4	LED_SEG2		SPI_MISO	UR0_TX	
4	4	7	7	4	PA3		ADC_IN5	LED_SEG3		SPI_SEL	UR0_RX	
5	5	8	8	5	PA4		ADC_IN6	LED_SEG4		SPI_SCK	UR1_TX	I2C_SCL
6	6	9	9	6	PA5		ADC_IN7	LED_SEG5		SPI_MOSI	UR1_RX	I2C_SDA
7	7	10			PA6		ADC_IN8	LED_SEG6		SPI_MISO		
8	8	11			PA7		ADC_IN9	LED_SEG7		SPI_SEL		
9					PC4		ADC_IN10	LED_COM4	SCTM2_CH0		UR1_TX	
10					PC5		ADC_IN11	LED_COM5	SCTM2_CH1		UR1_RX	
11					PC6			LED_COM6			UR0_TX	I2C_SCL
12					PC7			LED_COM7			UR0_RX	I2C_SDA
13	9	12	10	7	CLDO							
14	10	13	11	8	VDD							
15	11, EP*	14	12	9, 21, EP*	VSS							
16	12	15	13	10	nRST							
17					PB9	PB9 / WAKEUP1			SCTM0_CH0			
18	13				X32KIN	PB10		LED_SEG4	SCTM1_CH1	SPI_SEL	UR1_TX	
19	14				X32KOUT	PB11		LED_SEG5	SCTM1_CH0	SPI_SCK	UR1_RX	
20	15	16	14	11	RTCOUT	PB12 / WAKEUP0			SCTM0_CH1	SPI_MISO		
21	16	17	15	12	XTALIN	PB13		LED_SEG6	SCTM2_CH0		UR0_TX	I2C_SCL
22	17	18	16	13	XTALOUT	PB14		LED_SEG7	SCTM2_CH1		UR0_RX	I2C_SDA
23					PB15					SPI_SEL		I2C_SCL
24					PC0			LED_COM0	SCTM1_CH1	SPI_SCK		I2C_SDA
25					PA8			LED_COM1	SCTM2_CH1		UR0_TX	

Packages					Alternate Function Mapping							
					AF0	AF1	AF2	AF3	AF4	AF5	AF6	AF7
48 LQFP	32 QFN	28 SSOP	24 SSOP	24 QFN	System Default	System Other	ADC	LEDC	SCTM	SPI	UART	I ² C
26	18	19	17	14	PA9_BOOT	CKOUT			SCTM1_CH0	SPI_MOSI		
27					PA10			LED_COM2	SCTM0_CH0	SPI_MOSI	UR0_RX	
28					PA11			LED_COM3	SCTM0_CH1	SPI_MISO		
29	19	20	18	15	SWCLK	PA12						
30	20	21	19	16	SWDIO	PA13						
31	21	22			PA14			LED_COM0		SPI_SEL	UR1_TX	I ² C_SCL
32	22	23			PA15			LED_COM1	SCTM2_CH0	SPI_SCK	UR1_RX	I ² C_SDA
33	23	24	20	17	PB0			LED_SEG0	SCTM2_CH0	SPI_MOSI	UR0_TX	I ² C_SCL
34	24	25	21	18	PB1			LED_SEG1	SCTM2_CH1	SPI_MISO	UR0_RX	I ² C_SDA
35					PF0				SCTM1_CH0		UR0_TX	I ² C_SCL
36					PF1				SCTM1_CH1		UR0_RX	I ² C_SDA
37	25	26	22	19	PB2			LED_SEG2	SCTM0_CH1	SPI_SEL	UR1_TX	
38	26	27	23	20	PB3			LED_SEG3	SCTM0_CH0	SPI_SCK	UR1_RX	
39	27	28	24		PB4			LED_COM2		SPI_MOSI	UR1_TX	
40	28				PB5			LED_COM3		SPI_MISO	UR1_RX	
41					PC1			LED_COM4		SPI_SEL	UR1_TX	
42					PC2			LED_COM5		SPI_SCK		
43					PC3			LED_COM6		SPI_MOSI	UR1_RX	I ² C_SCL
44					PB6			LED_COM7		SPI_MISO		I ² C_SDA
45	29	1	1	22	PB7		ADC_IN0	LED_SEG4	SCTM0_CH0	SPI_MISO	UR0_TX	I ² C_SCL
46	30	2	2	23	PB8		ADC_IN1	LED_SEG5	SCTM0_CH1	SPI_SEL	UR0_RX	I ² C_SDA
47	31	3	3	24	ADVREFP							
48	32				VSSA							

Note: The EP is meant the exposed pad of the QFN package.

Table 4. Pin Description

Pin Number					Pin Name	Type ⁽¹⁾	I/O Structure ⁽²⁾	Output Driving	Description
48 LQFP	32 QFN	28 SSOP	24 SSOP	24 QFN					Default Function (AF0)
1	1	4	4	1	PA0	AI/O	5V	4/8/12/16 mA	PA0
2	2	5	5	2	PA1	AI/O	5V	4/8/12/16 mA	PA1
3	3	6	6	3	PA2	AI/O	5V	4/8/12/16 mA	PA2
4	4	7	7	4	PA3	AI/O	5V	4/8/12/16 mA	PA3
5	5	8	8	5	PA4	AI/O	5V	4/8/12/16 mA	PA4, this pin provides a UART_TX function in the Boot loader mode
6	6	9	9	6	PA5	AI/O	5V	4/8/12/16 mA	PA5, this pin provides a UART_RX function in the Boot loader mode
7	7	10			PA6	AI/O	5V	4/8/12/16 mA	PA6
8	8	11			PA7	AI/O	5V	4/8/12/16 mA	PA7
9					PC4	AI/O	5V	4/8/12/16 mA	PC4
10					PC5	AI/O	5V	4/8/12/16 mA	PC5
11					PC6	AI/O	—	—	PC6
12					PC7	AI/O	—	—	PC7
13	9	12	10	7	CLDO	P	—	—	Core power LDO output. It must be connected a 2.2 μF capacitor as close as possible between this pin and VSS
14	10	13	11	8	VDD	P	—	—	Voltage for digital I/O
15	11, EP	14	12	9, 21, EP	VSS	P	—	—	Ground reference for digital I/O
16	12	15	13	10	nRST ⁽³⁾	I	5V_PU	—	External reset
17					PB9 ⁽³⁾	I/O (V _{DD})	5V	4/8/12/16 mA	PB9
18	13				PB10 ⁽³⁾	AI/O (V _{DD})	5V	4/8/12/16 mA	X32KIN
19	14				PB11 ⁽³⁾	AI/O (V _{DD})	5V	4/8/12/16 mA	X32KOUT
20	15	16	14	11	PB12 ⁽³⁾	I/O (V _{DD})	5V	4/8/12/16 mA	RTCOUT
21	16	17	15	12	PB13	AI/O	5V	4/8/12/16 mA	XTALIN
22	17	18	16	13	PB14	AI/O	5V	4/8/12/16 mA	XTALOUT
23					PB15	I/O	5V	4/8/12/16 mA	PB15
24					PC0	I/O (V _{DD})	5V	4/8/12/16 mA	PC0
25					PA8	I/O (V _{DD})	5V	4/8/12/16 mA	PA8
26	18	19	17	14	PA9	I/O (V _{DD})	5V_PU	4/8/12/16 mA	PA9_BOOT
27					PA10	I/O (V _{DD})	5V	4/8/12/16 mA	PA10
28					PA11	I/O (V _{DD})	5V	4/8/12/16 mA	PA11
29	19	20	18	15	PA12	I/O (V _{DD})	5V_PU	4/8/12/16 mA	SWCLK

Pin Number					Pin Name	Type ⁽¹⁾	I/O Structure ⁽²⁾	Output Driving	Description
48 LQFP	32 QFN	28 SSOP	24 SSOP	24 QFN					Default Function (AF0)
30	20	21	19	16	PA13	I/O (V _{DD})	5V_PU	4/8/12/16 mA	SWDIO
31	21	22			PA14	I/O (V _{DD})	5V	4/8/12/16 mA	PA14
32	22	23			PA15	I/O (V _{DD})	5V	4/8/12/16 mA	PA15
33	23	24	20	17	PB0	I/O (V _{DD})	5V	4/8/12/16 mA	PB0
34	24	25	21	18	PB1	I/O (V _{DD})	5V	4/8/12/16 mA	PB1
35					PF0	I/O (V _{DD})	5V	4/8/12/16 mA	PF0
36					PF1	I/O (V _{DD})	5V	4/8/12/16 mA	PF1
37	25	26	22	19	PB2	I/O	5V	4/8/12/16 mA	PB2
38	26	27	23	20	PB3	I/O	5V	4/8/12/16 mA	PB3
39	27	28	24		PB4	I/O	5V	4/8/12/16 mA	PB4
40	28				PB5	I/O	5V	4/8/12/16 mA	PB5
41					PC1	I/O	5V	4/8/12/16 mA	PC1
42					PC2	I/O	5V	4/8/12/16 mA	PC2
43					PC3	I/O	5V	4/8/12/16 mA	PC3
44					PB6	I/O	5V	4/8/12/16 mA	PB6
45	29	1	1	22	PB7	AI/O	5V	4/8/12/16 mA	PB7
46	30	2	2	23	PB8	AI/O	5V	4/8/12/16 mA	PB8
47	31	3	3	24	ADVREFP	P	—	—	Positive reference voltage for the ADC
48	32				VSSA	P	—	—	Ground reference for the ADC

Note: 1. I = input, O = output, A = Analog port, P = Power Supply, V_{DD} = V_{DD} Power, EP = Exposed Pad.

2. 5V = 5 V operation I/O type, PU = Pull-up.

3. These pins are located at the V_{DD} power domain.

4. In the Boot loader mode, the UART interface is available for communication.

5 Electrical Characteristics

Absolute Maximum Ratings

The following table shows the absolute maximum ratings of the device. These are stress ratings only. Stresses beyond absolute maximum ratings may cause permanent damage to the device. Note that the device is not guaranteed to operate properly at the maximum ratings. Exposure to the absolute maximum rating conditions for extended periods may affect device reliability.

Table 5. Absolute Maximum Ratings

Symbol	Parameter	Min.	Max.	Unit
V _{DD}	External Main Supply Voltage	V _{SS} - 0.3	V _{SS} + 5.5	V
V _{DDA}	External Analog Supply Voltage	V _{SSA} - 0.3	V _{SSA} + 5.5	V
V _{IN}	Input Voltage on I/O	V _{SS} - 0.3	V _{DD} + 0.3	V
T _A	Ambient Operating Temperature Range	-40	85	°C
T _{STG}	Storage Temperature Range	-60	150	°C
T _J	Maximum Junction Temperature	—	125	°C
P _D	Total Power Dissipation	—	500	mW
V _{ESD}	Electrostatic Discharge Voltage – Human Body Mode	-4000	4000	V

Recommended DC Operating Conditions

Table 6. Recommended DC Operating Conditions

T_A = 25 °C, unless otherwise specified

Symbol	Parameter	Conditions	Min.	Typ.	Max.	Unit
V _{DD}	Operating Voltage	—	2.5	5.0	5.5	V
V _{ADVREFP}	ADC Positive Reference Voltage	—	2.5	5.0	5.5	V

Note: The V_{ADVREFP} power voltage needs below or equal to the V_{DD} power voltage.

On-Chip LDO Voltage Regulator Characteristics

Table 7. LDO Characteristics

T_A = 25 °C, unless otherwise specified

Symbol	Parameter	Conditions	Min.	Typ.	Max.	Unit
V _{LDO}	Internal Regulator Output Voltage	V _{DD} ≥ 2.5 V Regulator input @ I _{LDO} = 12 mA and voltage variant = ±5 %, After trimming	1.425	1.5	1.57	V
I _{LDO}	Output Current	V _{DD} = 2.5 V Regulator input @ V _{LDO} = 1.5 V	—	12	15	mA
C _{LDO}	External Filter Capacitor Value for Internal Core Power Supply	The capacitor value is dependent on the core power current consumption	1	2.2	—	μF

Power Consumption

The current consumption is influenced by several parameters and factors, including the operating voltage, ambient temperature, I/O pin loading, device software configuration, operating frequencies, I/O pin switching rate, program location in memory and executed binary code.

The MCU is configured under the following conditions for current consumption measured:

- All I/O pins are set to a high-impedance (floating) state.
- All peripherals are disabled unless specifically stated otherwise.
- The Flash memory access time is optimized using the minimum wait states number, depending on the f_{HCLK} frequency.
- When the peripherals are enabled, $f_{PCLK} = f_{HCLK}$.

Table 8. Power Consumption Characteristics

$T_A = 25\text{ }^{\circ}\text{C}$, unless otherwise specified

Symbol	Parameter	f_{HCLK}	Conditions	Typ.	Max @ T_A		Unit
					25 $^{\circ}\text{C}$	85 $^{\circ}\text{C}$	
I_{DD}	Supply Current (Run Mode)	16 MHz	$V_{DD} = 5\text{ V}$ HSI = 16 MHz	All peripherals enabled	3.35	3.60	mA
				All peripherals disabled	2.75	2.95	
		8 MHz	$V_{DD} = 5\text{ V}$ HSI = 16 MHz	All peripherals enabled	1.88	2.02	
				All peripherals disabled	1.57	1.69	
		32 kHz	$V_{DD} = 5\text{ V}$ LSI = 32 kHz LDO in LCM Mode	All peripherals enabled	26.39	32.72	μA
				All peripherals disabled	25.13	31.42	
	Supply Current (Sleep Mode)	16 MHz	$V_{DD} = 5\text{ V}$ HSI = 16 MHz	All peripherals enabled	1.16	1.24	mA
				All peripherals disabled	0.44	0.48	
		8 MHz	$V_{DD} = 5\text{ V}$ HSI = 16 MHz	All peripherals enabled	0.77	0.83	
				All peripherals disabled	0.41	0.45	
	Supply Current (Deep-Sleep1 Mode)	—	$V_{DD} = 5\text{ V}$, HSI/HSE clock off, LDO in LCM Mode, LSE off, LSI on, RTC on	20.27	26.39	—	μA
	Supply Current (Deep-Sleep2 Mode)	—	$V_{DD} = 5\text{ V}$, HSI/HSE clock off, LDO off, DMOS on, LSE off, LSI on, RTC on	3.45	5.14	—	μA

Note: 1. HSE means high speed external oscillator. HSI means 16 MHz high speed internal oscillator.
 2. LSE means 32.768 kHz low speed external oscillator. LSI means 32 kHz low speed internal oscillator.
 3. RTC means real-time clock.
 4. Code = while (1) { 208 NOP } executed in Flash.

Reset and Supply Monitor Characteristics

Table 9. V_{DD} Power Reset Characteristics

T_A = 25 °C, unless otherwise specified

Symbol	Parameter	Conditions	Min.	Typ.	Max.	Unit
V _{POR}	Power On Reset Threshold (Rising Voltage on V _{DD})	T _A = -40 °C ~ 85 °C	2.22	2.35	2.48	V
V _{PDR}	Power Down Reset Threshold (Falling Voltage on V _{DD})		2.12	2.2	2.33	V
V _{PORHYST}	POR Hysteresis	—	—	150	—	mV
t _{POR}	Reset Delay Time	V _{DD} = 5.0 V	—	0.1	0.2	ms

Note: 1. Data based on characterization results only, not tested in production.

2. If the LDO is turned on, the V_{DD} POR has to be in the de-assertion condition. When the V_{DD} POR is in the assertion state then the LDO will be turned off.

Table 10. LVD / BOD Characteristics

T_A = 25 °C, unless otherwise specified

Symbol	Parameter	Conditions		Min.	Typ.	Max.	Unit
V _{BOD}	Voltage of Brown Out Detection	After factory-trimmed, V _{DD} falling edge		2.37	2.45	2.53	V
V _{LVD}	Voltage of Low Voltage Detection	V _{DD} falling edge	LVDS = 000	2.57	2.65	2.73	V
			LVDS = 001	2.77	2.85	2.93	V
			LVDS = 010	2.97	3.05	3.13	V
			LVDS = 011	3.17	3.25	3.33	V
			LVDS = 100	3.37	3.45	3.53	V
			LVDS = 101	4.15	4.25	4.35	V
			LVDS = 110	4.35	4.45	4.55	V
			LVDS = 111	4.55	4.65	4.75	V
V _{LVDHST}	LVD Hysteresis	V _{DD} = 5.0 V	—	—	100	—	mV
t _{suLVD}	LVD Setup Time	V _{DD} = 5.0 V	—	—	—	5	μs
t _{atLVD}	LVD Active Delay Time	V _{DD} = 5.0 V	—	—	200	—	μs
I _{DDLVD}	Operation Current ⁽²⁾	V _{DD} = 5.0 V	—	—	10	20	μA

Note: 1. Data based on characterization results only, not tested in production.

2. Bandgap current is not included.

3. LVDS field is in the PWRCU LVDCSR register.

External Clock Characteristics

Table 11. High Speed External Clock (HSE) Characteristics

T_A = 25 °C, unless otherwise specified

Symbol	Parameter	Conditions	Min.	Typ.	Max.	Unit
V _{DD}	Operation Range	T _A = -40 °C ~ 85 °C	2.5	—	5.5	V
f _{HSE}	HSE Frequency	V _{DD} = 2.5 V ~ 5.0 V	4	—	16	MHz
C _L	Load Capacitance	V _{DD} = 5.0 V, R _{ESR} = 100 Ω @ 16 MHz	—	—	12	pF
R _{FHSE}	Internal Feedback Resistor between XTALIN and XTALOUT pins	V _{DD} = 5.0 V	—	0.5	—	MΩ
R _{ESR}	Equivalent Series Resistance	V _{DD} = 5.0 V, C _L = 12 pF @ 16 MHz, HSEGAIn = 0	—	—	110	Ω
		V _{DD} = 2.5 V, C _L = 12 pF @ 16 MHz, HSEGAIn = 1				
D _{HSE}	HSE Oscillator Duty Cycle	—	40	—	60	%
I _{DDHSE}	HSE Oscillator Current Consumption	V _{DD} = 5.0 V, R _{ESR} = 100 Ω, C _L = 12 pF @ 8 MHz, HSEGAIn = 0	—	0.85	—	mA
		V _{DD} = 5.0 V, R _{ESR} = 25 Ω, C _L = 12 pF @ 16 MHz, HSEGAIn = 1	—	3.0	—	
I _{PWDHSE}	HSE Oscillator Power Down Current	V _{DD} = 5.0 V	—	—	0.01	μA
t _{SUHSE}	HSE Oscillator Startup Time	V _{DD} = 5.0 V	—	—	4	ms

Table 12. Low Speed External Clock (LSE) Characteristics

T_A = 25 °C, unless otherwise specified

Symbol	Parameter	Conditions	Min.	Typ.	Max.	Unit
V _{DD}	Operation Range	T _A = -40 °C ~ 85 °C	2.5	—	5.5	V
f _{CK_LSE}	LSE Frequency	V _{DD} = 2.5 V ~ 5.5 V	—	32.768	—	kHz
R _F	Internal feedback resistor	—	—	10	—	MΩ
R _{ESR}	Equivalent Series Resistance	V _{DD} = 5.0 V	30	—	TBD	kΩ
C _L	Recommended load capacitances	V _{DD} = 5.0 V	6	—	TBD	pF
I _{DDLSE}	Oscillator Supply Current (High Current Mode)	f _{CK_LSE} = 32.768 kHz, R _{ESR} = 50 kΩ, C _L ≥ 7 pF V _{DD} = 2.5 V ~ 5.5 V T _A = -40 °C ~ 85 °C	—	3.3	6.3	μA
	Oscillator Supply Current (Low Current Mode)	f _{CK_LSE} = 32.768 kHz, R _{ESR} = 50 kΩ, C _L < 7 pF V _{DD} = 2.5 V ~ 5.5 V T _A = -40 °C ~ 85 °C	—	1.8	3.3	μA
	Power Down Current	—	—	—	0.01	μA
t _{SULSE}	LSE Oscillator Startup Time (Low Current Mode)	f _{CK_LSE} = 32.768 kHz, V _{DD} = 2.5 V ~ 5.5 V	500	—	—	ms

Note: The following guidelines are recommended to increase the stability of the crystal circuit of the HSE / LSE clock in the PCB layout.

1. The crystal oscillator should be located as close as possible to the MCU to keep the trace length as short as possible to reduce any parasitic capacitance.
2. Shield lines in the vicinity of the crystal by using a ground plane to isolate signals and reduce noise.
3. Keep any high frequency signal lines away from the crystal area to prevent the crosstalk adverse effects.

Internal Clock Characteristics

Table 13. High Speed Internal Clock (HSI) Characteristics

$T_A = 25\text{ }^{\circ}\text{C}$, unless otherwise specified

Symbol	Parameter	Conditions	Min.	Typ.	Max.	Unit
V_{DD}	Operation Range	$T_A = -40\text{ }^{\circ}\text{C} \sim 85\text{ }^{\circ}\text{C}$	2.5	—	5.5	V
f_{HSI}	HSI Frequency	$V_{DD} = 5\text{ V @ } 25\text{ }^{\circ}\text{C}$	—	16	—	MHz
ACC_{HSI}	Factory Calibrated HSI Oscillator Frequency Accuracy	$V_{DD} = 2.5\text{ V} \sim 5.5\text{ V}, T_A = 25\text{ }^{\circ}\text{C}$	-1	—	1	%
		$V_{DD} = 2.5\text{ V} \sim 5.5\text{ V}$ $T_A = -25\text{ }^{\circ}\text{C} \sim 85\text{ }^{\circ}\text{C}$	-2.5	—	2	%
		$V_{DD} = 2.5\text{ V} \sim 5.5\text{ V}$ $T_A = -40\text{ }^{\circ}\text{C} \sim 85\text{ }^{\circ}\text{C}$	-4	—	3	%
Duty	Duty Cycle	$f_{HSI} = 16\text{ MHz}$	35	—	65	%
I_{DDHSI}	Oscillator Supply Current	$f_{HSI} = 16\text{ MHz}$	—	—	140	μA
	Power Down Current	@ $V_{DD} = 2.5\text{ V} \sim 5.5\text{ V}$	—	—	0.01	μA
T_{SUHSI}	HSI Oscillator Startup Time	$f_{HSI} = 16\text{ MHz}$	—	—	20	μs

Table 14. Low Speed Internal Clock (LSI) Characteristics

$T_A = 25\text{ }^{\circ}\text{C}$, unless otherwise specified

Symbol	Parameter	Conditions	Min.	Typ.	Max.	Unit
V_{DD}	Operation Range	$T_A = -40\text{ }^{\circ}\text{C} \sim 85\text{ }^{\circ}\text{C}$	2.5	—	5.5	V
f_{LSI}	LSI Frequency	$V_{DD} = 5.0\text{ V}, T_A = -40\text{ }^{\circ}\text{C} \sim 85\text{ }^{\circ}\text{C}$	21	32	43	kHz
ACC_{LSI}	LSI Frequency Accuracy	$V_{DD} = 5.0\text{ V}$, with factory-trimmed	-10	—	+10	%
$I_{DDL SI}$	LSI Oscillator Operating Current	$V_{DD} = 5.0\text{ V}$	—	0.5	0.8	μA
t_{SULSI}	LSI Oscillator Startup Time	$V_{DD} = 5.0\text{ V}$	—	—	100	μs

Memory Characteristics

Table 15. Flash Memory Characteristics

$T_A = 25\text{ }^{\circ}\text{C}$, unless otherwise specified

Symbol	Parameter	Conditions	Min.	Typ.	Max.	Unit
N_{ENDU}	Number of Guaranteed Program / Erase Cycles before Failure (Endurance)	$T_A = -40\text{ }^{\circ}\text{C} \sim 85\text{ }^{\circ}\text{C}$	20	—	—	K cycles
t_{RET}	Data Retention Time	$T_A = -40\text{ }^{\circ}\text{C} \sim 85\text{ }^{\circ}\text{C}$	10	—	—	Years
t_{PROG}	Word Programming Time	$T_A = -40\text{ }^{\circ}\text{C} \sim 85\text{ }^{\circ}\text{C}$	20	—	—	μs
t_{ERASE}	Page Erase Time	$T_A = -40\text{ }^{\circ}\text{C} \sim 85\text{ }^{\circ}\text{C}$	2	—	—	ms
t_{MERASE}	Mass Erase Time	$T_A = -40\text{ }^{\circ}\text{C} \sim 85\text{ }^{\circ}\text{C}$	10	—	—	ms

I/O Port Characteristics

Table 16. I/O Port Characteristics

$T_A = 25\text{ }^{\circ}\text{C}$, unless otherwise specified

Symbol	Parameter	Conditions	Min.	Typ.	Max.	Unit
I_{IL}	Low Level Input Current	5.0 V I/O	—	—	3	μA
		Reset pin	—	—	3	μA
I_{IH}	High Level Input Current	5.0 V I/O	—	—	3	μA
		Reset pin	—	—	3	μA
V_{IL}	Low Level Input Voltage	5.0 V I/O	-0.5	—	$V_{DD} \times 0.35$	V
		Reset pin	-0.5	—	$V_{DD} \times 0.35$	V
V_{IH}	High Level Input Voltage	5.0 V I/O	$V_{DD} \times 0.65$	—	$V_{DD} + 0.5$	V
		Reset pin	$V_{DD} \times 0.65$	—	$V_{DD} + 0.5$	V
V_{HYS}	Schmitt Trigger Input Voltage Hysteresis	5.0 V I/O	—	$0.12 \times V_{DD}$	—	mV
		Reset pin	—	$0.12 \times V_{DD}$	—	mV
I_{OL}	Low Level Output Current (GPIO Sink Current)	5.0 V I/O 4 mA drive, $V_{OL} = 0.6\text{ V}$	4	—	—	mA
		5.0 V I/O 8 mA drive, $V_{OL} = 0.6\text{ V}$	8	—	—	mA
		5.0 V I/O 12 mA drive, $V_{OL} = 0.6\text{ V}$	12	—	—	mA
		5.0 V I/O 16 mA drive, $V_{OL} = 0.6\text{ V}$	16	—	—	mA
I_{OH}	High Level Output Current (GPIO Source Current)	5.0 V I/O 4 mA drive, $V_{OH} = V_{DD} - 0.6\text{ V}$	—	4	—	mA
		5.0 V I/O 8 mA drive, $V_{OH} = V_{DD} - 0.6\text{ V}$	—	8	—	mA
		5.0 V I/O 12 mA drive, $V_{OH} = V_{DD} - 0.6\text{ V}$	—	12	—	mA
		5.0 V I/O 16 mA drive, $V_{OH} = V_{DD} - 0.6\text{ V}$	—	16	—	mA
V_{OL}	Low Level Output Voltage	5.0 V 4 mA drive I/O, $I_{OL} = 4\text{ mA}$	—	—	0.6	V
		5.0 V 8 mA drive I/O, $I_{OL} = 8\text{ mA}$	—	—	0.6	V
		5.0 V 12 mA drive I/O, $I_{OL} = 12\text{ mA}$	—	—	0.6	V
		5.0 V 16 mA drive I/O, $I_{OL} = 16\text{ mA}$	—	—	0.6	V
V_{OH}	High Level Output Voltage	5.0 V 4 mA drive I/O, $I_{OH} = 4\text{ mA}$	$V_{DD} - 0.6$	—	—	V
		5.0 V 8 mA drive I/O, $I_{OH} = 8\text{ mA}$	$V_{DD} - 0.6$	—	—	V
		5.0 V 12 mA drive I/O, $I_{OH} = 12\text{ mA}$	$V_{DD} - 0.6$	—	—	V
		5.0 V 16 mA drive I/O, $I_{OH} = 16\text{ mA}$	$V_{DD} - 0.6$	—	—	V
R_{PU}	Internal Pull-up Resistor	$V_{DD} = 5.0\text{ V}$	—	50	—	k Ω
R_{SPU}	Strong Pull-up Resistor	—	—	5	—	k Ω
R_{PD}	Internal Pull-down Resistor	$V_{DD} = 5.0\text{ V}$	—	50	—	k Ω

ADC Characteristics

Table 17. ADC Characteristics

$T_A = 25\text{ }^{\circ}\text{C}$, unless otherwise specified

Symbol	Parameter	Conditions	Min.	Typ.	Max.	Unit
V_{DDA}	Operating Voltage	—	2.5	5.0	5.5	V
V_{ADCIN}	A/D Converter Input Voltage Range	—	0	—	V_{REF+}	V
V_{REF+}	A/D Converter Positive Reference Voltage	—	—	—	V_{DDA}	V
I_{ADC}	Current Consumption	$V_{DDA} = 5.0\text{ V}$, 500 ksps	—	1.4	1.5	mA
I_{ADC_DN}	Power Down Current Consumption	$V_{DDA} = 5.0\text{ V}$	—	—	0.1	μA
f_{ADC}	A/D Converter Clock Frequency	—	0.7	—	8	MHz
f_S	Sampling Rate	—	50	—	500	ksps
t_{DL}	Data Latency	—	—	12.5	—	$1/f_{ADC}$ Cycles
$t_{S\&H}$	Sampling & Hold Time	—	—	3.5	—	$1/f_{ADC}$ Cycles
$t_{ADCCONV}$	A/D Converter Conversion Time	ADST[7:0] = 2	—	16	—	$1/f_{ADC}$ Cycles
R_i	Input Sampling Switch Resistance	—	—	—	1	k Ω
C_i	Input Sampling Capacitance	No pin/pad capacitance included	—	4	—	pF
t_{SU}	Startup Time	—	—	—	1	μs
N	Resolution	—	—	12	—	Bits
INL	Integral Non-linearity Error	$f_S = 500\text{ ksps}$, $V_{DDA} = 5.0\text{ V}$	—	± 2	± 5	LSB
DNL	Differential Non-linearity Error	$f_S = 500\text{ ksps}$, $V_{DDA} = 5.0\text{ V}$	—	± 1	—	LSB
E_O	Offset Error	—	—	—	± 10	LSB
E_G	Gain Error	—	—	—	± 10	LSB

Note: 1. Data based on characterization results only, not tested in production.

2. The figure below shows the equivalent circuit of the A/D Converter Sample-and-Hold input stage where C_i is the storage capacitor, R_i is the resistance of the sampling switch and R_S is the output impedance of the signal source V_S . Normally the sampling phase duration is approximately, $3.5/f_{ADC}$. The capacitance, C_i , must be charged within this time frame and it must be ensured that the voltage at its terminals becomes sufficiently close to V_S for accuracy. To guarantee this, R_S is not allowed to have an arbitrarily large value.

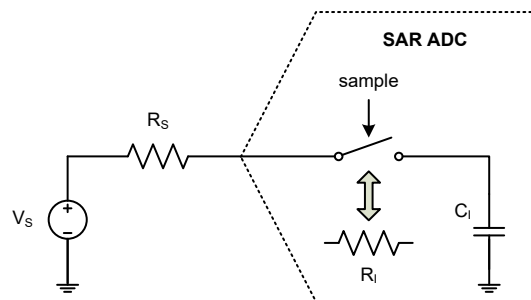


Figure 9. ADC Sampling Network Model

The worst case occurs when the extremities of the input range (0 V and V_{REF+}) are sampled consecutively. In this situation a sampling error below $\frac{1}{4}$ LSB is ensured by using the following equation:

$$R_S < \frac{3.5}{f_{ADC} C_1 \ln(2^{N+2})} - R_I$$

Where f_{ADC} is the ADC clock frequency and N is the ADC resolution (N = 12 in this case). A safe margin should be considered due to the pin/pad parasitic capacitances, which are not accounted for in this simple model.

If, in a system where the A/D Converter is used, there are no rail-to-rail input voltage variations between consecutive sampling phases, R_S may be larger than the value indicated by the equation above.

Internal Reference Voltage Characteristics

Table 18. Internal Reference Voltage Characteristics

$T_A = 25\text{ }^{\circ}\text{C}$, unless otherwise specified.

Symbol	Parameter	Conditions	Min.	Typ.	Max.	Unit
V_{DDA}	Operating Voltage	—	2.8	—	5.5	V
V_{REF}	Internal Reference Voltage after Factory Trimming, @ $T_A = 25\text{ }^{\circ}\text{C}$	$V_{DDA} \geq 2.8\text{ V}$ VREFSEL[1:0] = 00	2.48	2.5	2.53	V
		$V_{DDA} \geq 3.3\text{ V}$ VREFSEL[1:0] = 01	2.97	3.0	3.03	
		$V_{DDA} \geq 4.3\text{ V}$ VREFSEL[1:0] = 10	3.96	4.0	4.04	
		$V_{DDA} \geq 4.8\text{ V}$ VREFSEL[1:0] = 11	4.46	4.5	4.55	
ACC_{VREF}	Reference Voltage Accuracy after Trimming	$V_{DDA} = 2.8\text{ V} \sim 5.5\text{ V}$, $V_{REF} = 2.5\text{ V}$, $T_A = -40\text{ }^{\circ}\text{C} \sim 85\text{ }^{\circ}\text{C}$	-3.5	—	3.5	%
t_{STABLE}	Reference Voltage Stable Time	—	—	—	100	ms
t_{SREFV}	ADC Sampling Time when Reading Reference Voltage	—	10	—	—	μs
I_{DD}	Operating Current	—	—	50	70	μA
I_{DDPWD}	Power Down Current	—	—	—	0.01	μA

Note: 1. Data based on characterization results only, not tested in production.

2. The trimming bits of the internal reference voltage are 7-bit resolution.

SCTM Characteristics

Table 19. SCTM Characteristics

Symbol	Parameter	Conditions	Min.	Typ.	Max.	Unit
f_{TM}	Timer Clock Source for SCTM	—	—	—	f_{PCLK}	MHz
t_{RES}	Timer Resolution Time	—	1	—	—	$1/f_{TM}$
f_{EXT}	External Signal Frequency on Channel	—	—	—	1/2	f_{TM}
RES	Timer Resolution	—	—	—	16	Bits

I²C Characteristics

Table 20. I²C Characteristics

Symbol	Parameter	Standard Mode		Fast Mode		Fast Plus Mode		Unit
		Min.	Max.	Min.	Max.	Min.	Max.	
f _{SCL}	SCL Clock Frequency	—	100	—	400	—	1000	kHz
t _{SCL(H)}	SCL Clock High Time	4.5	—	1.125	—	0.45	—	μs
t _{SCL(L)}	SCL Clock Low Time	4.5	—	1.125	—	0.45	—	μs
t _{FALL}	SCL and SDA Fall Time	—	1.3	—	0.34	—	0.135	μs
t _{RISE}	SCL and SDA Rise Time	—	1.3	—	0.34	—	0.135	μs
t _{SU(SDA)}	SDA Data Setup Time	500	—	125	—	50	—	ns
t _{H(SDA)}	SDA Data Hold Time ⁽⁵⁾	0	—	0	—	0	—	ns
	SDA Data Hold Time ⁽⁶⁾	—	1.6	—	0.475	—	0.25	μs
t _{VD(SDA)}	SDA Data Valid Time	—	1.6	—	0.475	—	0.25	μs
t _{SU(STA)}	START Condition Setup Time	500	—	125	—	50	—	ns
t _{H(STA)}	START Condition Hold Time	0	—	0	—	0	—	ns
t _{SU(STO)}	STOP Condition Setup Time	500	—	125	—	50	—	ns

Note: 1. Data based on characterization results only, not tested in production.

2. To achieve 100 kHz standard mode, the peripheral clock frequency must be higher than 2 MHz.

3. To achieve 400 kHz fast mode, the peripheral clock frequency must be higher than 8 MHz.

4. To achieve 1 MHz fast plus mode, the peripheral clock frequency must be higher than 16 MHz.

5. The above characteristic parameters of the I²C bus timing are based on: COMBFILTEREN = 0 and SEQFILTER = 00.

6. The above characteristic parameters of the I²C bus timing are based on: COMBFILTEREN = 1 and SEQFILTER = 00.

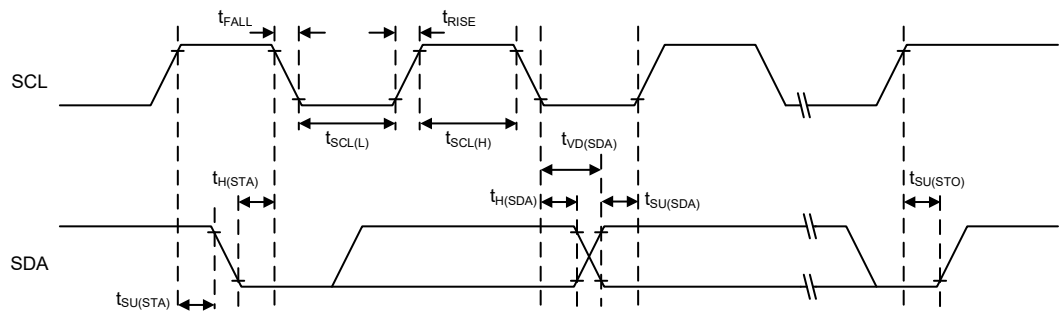


Figure 10. I²C Timing Diagram

SPI Characteristics

Table 21. SPI Characteristics

Symbol	Parameter	Conditions	Min.	Typ.	Max.	Unit
SPI Master Mode						
f_{SCK}	SPI Master Output SCK Clock Frequency	Master mode SPI peripheral clock frequency f_{PCLK}	—	—	$f_{PCLK}/2$	MHz
$t_{SCK(H)}$ $t_{SCK(L)}$	SCK Clock High and Low Time	—	$t_{SCK}/2$ - 2	—	$t_{SCK}/2$ + 1	ns
$t_{V(MO)}$	Data Output Valid Time	—	—	—	5	ns
$t_{H(MO)}$	Data Output Hold Time	—	2	—	—	ns
$t_{SU(MI)}$	Data Input Setup Time	—	5	—	—	ns
$t_{H(MI)}$	Data Input Hold Time	—	5	—	—	ns
SPI Slave Mode						
f_{SCK}	SPI Slave Input SCK Clock Frequency	Slave mode, SPI peripheral clock frequency f_{PCLK}	—	—	$f_{PCLK}/3$	MHz
$Duty_{SCK}$	SPI Slave Input SCK Clock Duty Cycle	—	30	—	70	%
$t_{SU(SEL)}$	SEL Enable Setup Time	—	$3 t_{PCLK}$	—	—	ns
$t_{H(SEL)}$	SEL Enable Hold Time	—	$2 t_{PCLK}$	—	—	ns
$t_{A(SO)}$	Data Output Access Time	—	—	—	$3 t_{PCLK}$	ns
$t_{DIS(SO)}$	Data Output Disable Time	—	—	—	10	ns
$t_{V(SO)}$	Data Output Valid Time	—	—	—	25	ns
$t_{H(SO)}$	Data Output Hold Time	—	15	—	—	ns
$t_{SU(SI)}$	Data Input Setup Time	—	5	—	—	ns
$t_{H(SI)}$	Data Input Hold Time	—	4	—	—	ns

Note: 1. f_{SCK} is SPI output/input clock frequency and $t_{SCK} = 1/f_{SCK}$.
2. f_{PCLK} is SPI peripheral clock frequency and $t_{PCLK} = 1/f_{PCLK}$.

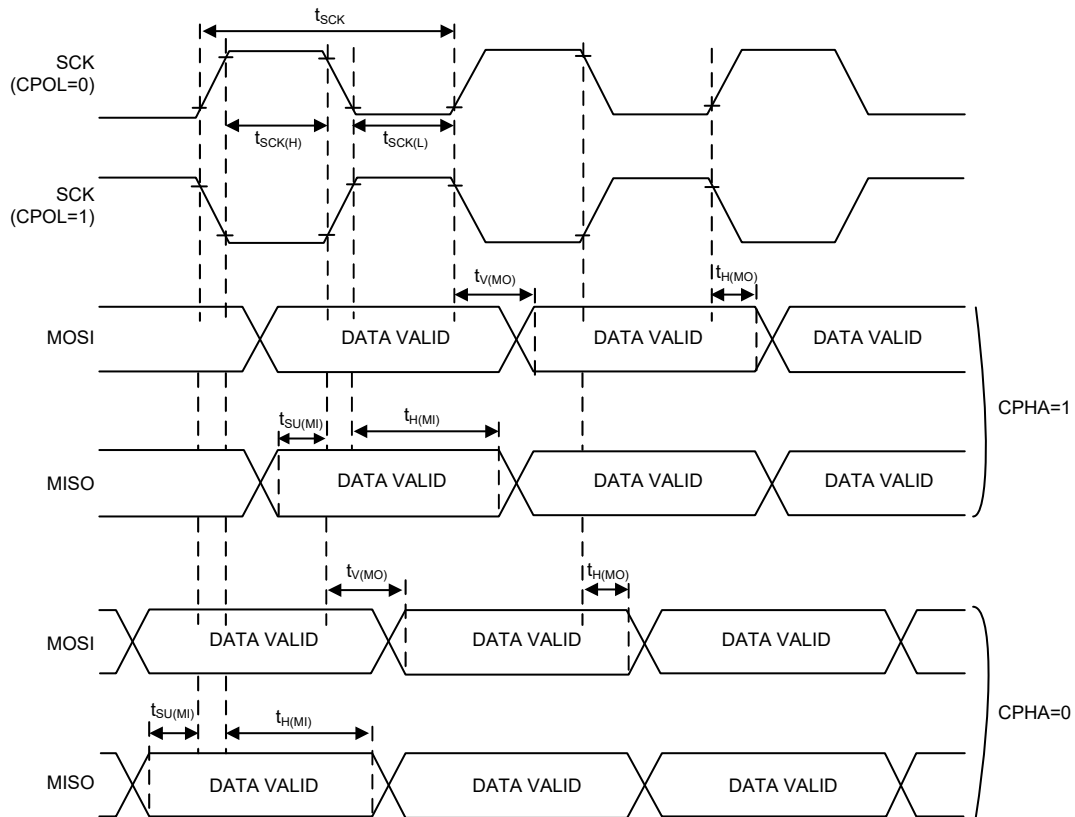


Figure 11. SPI Timing Diagram – SPI Master Mode

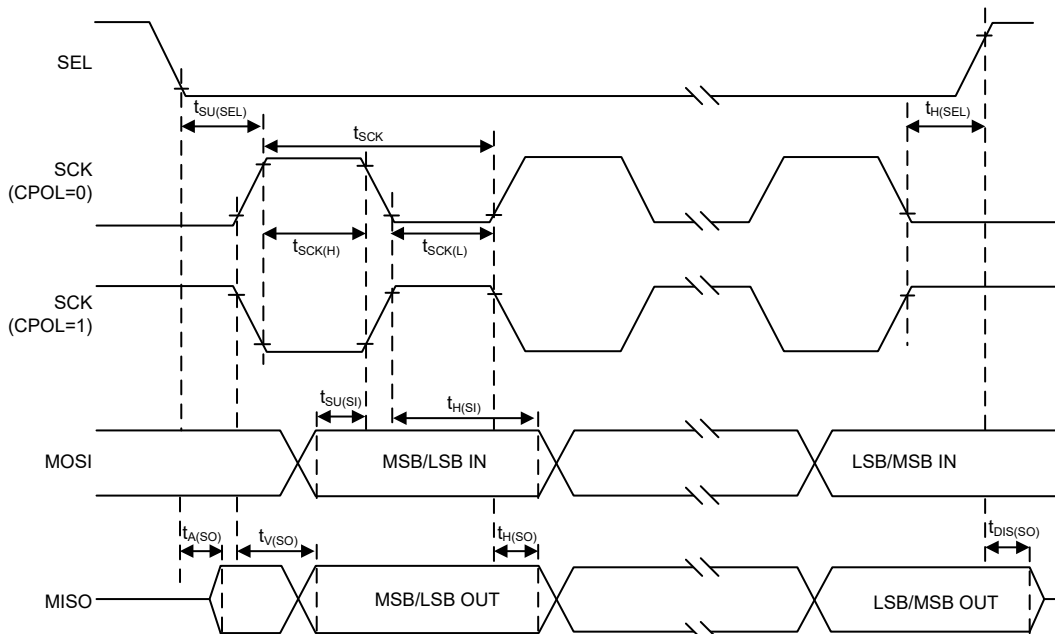


Figure 12. SPI Timing Diagram – SPI Slave Mode with CPHA = 1

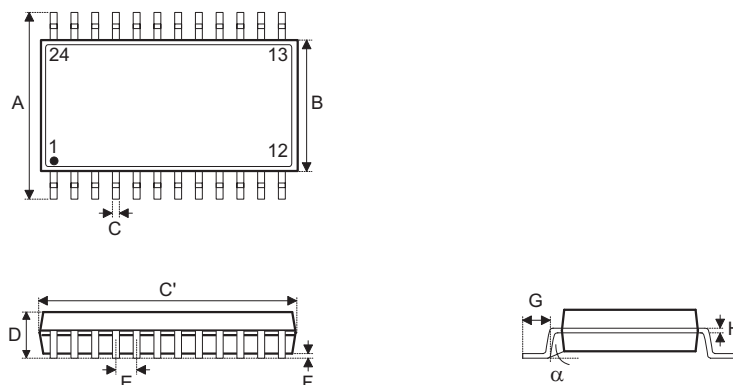
6 Package Information

Note that the package information provided here is for consultation purposes only. As this information may be updated at regular intervals users are reminded to consult the [Holtek website](#) for the latest version of the [Package/Carton Information](#).

Additional supplementary information with regard to packaging is listed below. Click on the relevant section to be transferred to the relevant website page.

- Package Information (include Outline Dimensions, Product Tape and Reel Specifications)
- The Operation Instruction of Packing Materials
- Carton information

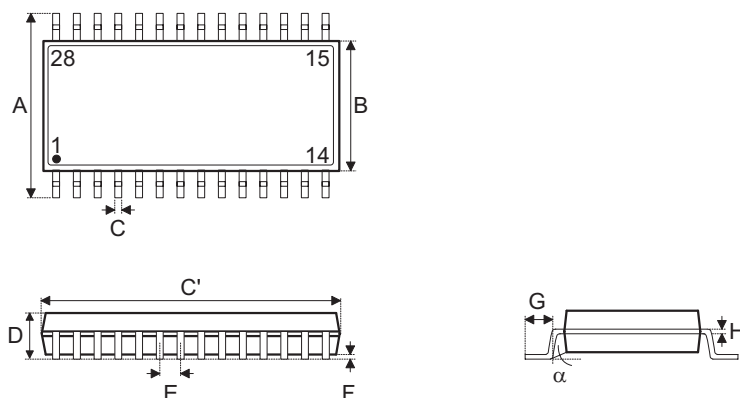
24-pin SSOP (150mil) Outline Dimensions



Symbol	Dimensions in inch		
	Min.	Nom.	Max.
A		0.236 BSC	
B		0.154 BSC	
C	0.008	—	0.012
C'		0.341 BSC	
D	—	—	0.069
E		0.025 BSC	
F	0.004	—	0.010
G	0.016	—	0.050
H	0.004	—	0.010
α	0°	—	8°

Symbol	Dimensions in mm		
	Min.	Nom.	Max.
A		6.00 BSC	
B		3.90 BSC	
C	0.20	—	0.30
C'		8.66 BSC	
D	—	—	1.75
E		0.635 BSC	
F	0.10	—	0.25
G	0.41	—	1.27
H	0.10	—	0.25
α	0°	—	8°

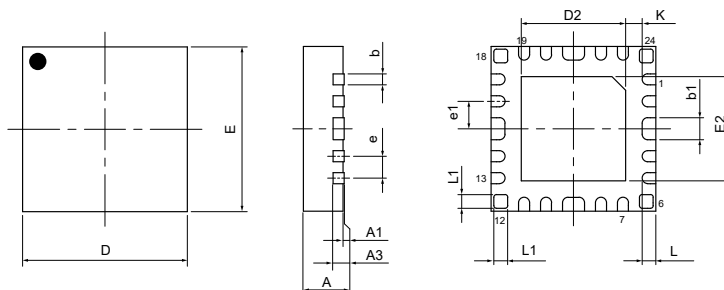
28-pin SSOP (150mil) Outline Dimensions



Symbol	Dimensions in inch		
	Min.	Nom.	Max.
A		0.236 BSC	
B		0.154 BSC	
C	0.008	—	0.012
C'		0.390 BSC	
D	—	—	0.069
E		0.025 BSC	
F	0.004	—	0.010
G	0.016	—	0.050
H	0.004	—	0.010
α	0°	—	8°

Symbol	Dimensions in mm		
	Min.	Nom.	Max.
A		6.00 BSC	
B		3.90 BSC	
C	0.20	—	0.30
C'		9.90 BSC	
D	—	—	1.75
E		0.635 BSC	
F	0.10	—	0.25
G	0.41	—	1.27
H	0.10	—	0.25
α	0°	—	8°

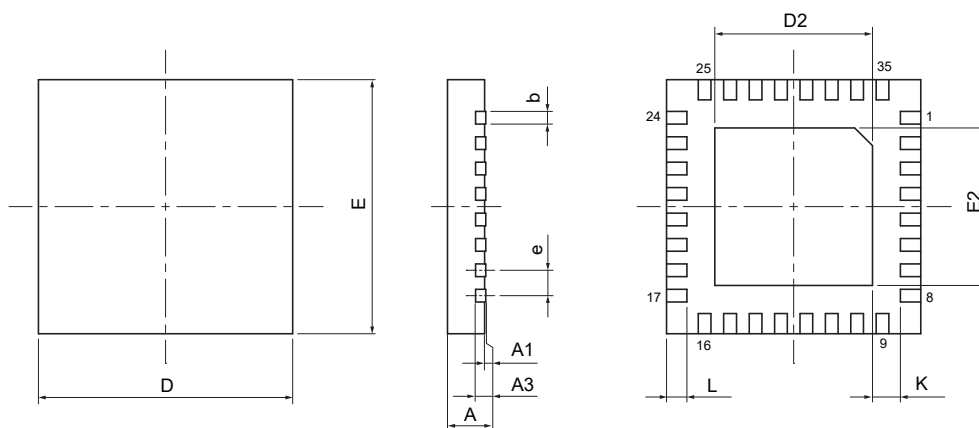
SAW Type 24-pin QFN (3mm×3mm×0.55mm) Outline Dimensions



Symbol	Dimensions in inch		
	Min.	Nom.	Max.
A	0.020	0.022	0.024
A1	0.000	0.001	0.002
A3	0.006 REF		
b	0.006	0.008	0.010
b1	0.014	0.016	0.018
D	0.118 BSC		
E	0.118 BSC		
e	0.016 BSC		
e1	0.020 BSC		
D2	0.073	—	0.077
E2	0.073	—	0.077
L	0.006	0.010	0.014
L1	0.008	0.010	0.012
K	0.008	—	—
T	0.000	0.002	0.004

Symbol	Dimensions in mm		
	Min.	Nom.	Max.
A	0.50	0.55	0.60
A1	0.00	0.02	0.05
A3	—	0.15 REF	—
b	0.15	0.20	0.25
b1	0.35	0.40	0.45
D	—	3.00 BSC	—
E	—	3.00 BSC	—
e	—	0.40 BSC	—
e1	—	0.50 BSC	—
D2	1.85	—	1.95
E2	1.85	—	1.95
L	0.15	0.25	0.35
L1	0.20	0.25	0.30
K	0.20	—	—
T	0.00	0.05	0.10

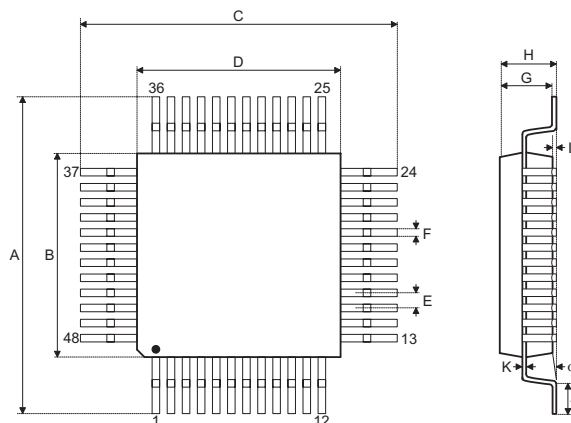
SAW Type 32-pin QFN (4mm×4mm×0.75mm) Outline Dimensions



Symbol	Dimensions in inch		
	Min.	Nom.	Max.
A	0.028	0.030	0.031
A1	0.000	0.001	0.002
A3	0.008 REF		
b	0.006	0.008	0.010
D	0.157 BSC		
E	0.157 BSC		
e	0.016 BSC		
D2	0.100	—	0.108
E2	0.100	—	0.108
L	0.010	—	0.018
K	0.008	—	—

Symbol	Dimensions in mm		
	Min.	Nom.	Max.
A	0.70	0.75	0.80
A1	0.00	0.02	0.05
A3	0.203 REF		
b	0.15	0.20	0.25
D	4.00 BSC		
E	4.00 BSC		
e	0.40 BSC		
D2	2.55	—	2.75
E2	2.55	—	2.75
L	0.25	—	0.45
K	0.20	—	—

48-pin LQFP (7mm×7mm) Outline Dimensions



Symbol	Dimensions in inch		
	Min.	Nom.	Max.
A	0.354 BSC		
B	0.276 BSC		
C	0.354 BSC		
D	0.276 BSC		
E	0.020 BSC		
F	0.007	0.009	0.011
G	0.053	0.055	0.057
H	—	—	0.063
I	0.002	—	0.006
J	0.018	0.024	0.030
K	0.004	—	0.008
α	0°	—	7°

Symbol	Dimensions in mm		
	Min.	Nom.	Max.
A	9.00 BSC		
B	7.00 BSC		
C	9.00 BSC		
D	7.00 BSC		
E	0.50 BSC		
F	0.17	0.22	0.27
G	1.35	1.40	1.45
H	—	—	1.60
I	0.05	—	0.15
J	0.45	0.60	0.75
K	0.09	—	0.20
α	0°	—	7°

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